

<b>Notice of References Cited</b>	Application/Control No. 10/552,469		Applicant(s)/Patent Under Reexamination MIYAWAKI ET AL.	
	Examiner Truc T. T. Nguyen		Art Unit 2833	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,241,545	06-2001	Bricaud et al.	439/326
*	B	US-6,808,424	10-2004	Kaneshiro et al.	439/638
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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